

**Notice of References Cited**

Application/Control No.

09/775,760

Applicant(s)/Patent Under  
Reexamination  
MALLON ET AL.

Examiner

Devesh Khare

Art Unit

1623

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-3,835,006	09-1974	Fujita et al.	204/180
	B	US-4,246,092	01-1981	Perry et al.	204/301
	C	US-6,482,940	11-2002	Klohr et al.	536/84
	D	US-2002/0016452	02-2002	Obara et al.	536/88
	E	US-2002/0168407	11-2002	Koch et al.	424/480
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	DE 16 68 347	09-1971	Germany	Warzecha et al.	-
*	O	JP 01-149801	06-1989	Japan	Takahashi et al.	-
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.